

STN	Špecifikácia metód a meracích prístrojov na meranie rádiového rušenia a odolnosti proti nemu. Časť 1-2: Meracie prístroje na meranie rádiového rušenia a odolnosti proti nemu. Spájacie zariadenia pre meranie rušenia šíreného vedením.	STN EN 55016-1-2
		33 4216

Táto norma obsahuje anglickú verziu európskej normy.
This standard includes the English version of the European Standard.

Táto norma bola oznámená vo Vestníku ÚNMS SR č. 11/14

Obsahuje: CISPR 16-1-2:2014, EN 55016-1-2:2014

Oznámením tejto normy sa od 25.04.2017 ruší
STN EN 55016-1-2 (33 4216) z mája 2005

119772

Úrad pre normalizáciu, metrológiu a skúšobníctvo SR, odbor SÚTN, 2014
Podľa zákona č. 264/1999 Z. z. v znení neskorších predpisov sa môžu slovenské technické normy
rozmnožovať a rozširovať iba so súhlasom Úradu pre normalizáciu, metrológiu a skúšobníctvo SR.

EUROPEAN STANDARD
NORME EUROPÉENNE
EUROPÄISCHE NORM

EN 55016-1-2

July 2014

ICS 33.100.10; 33.100.20

Supersedes EN 55016-1-2:2004

English Version

**Specification for radio disturbance and immunity measuring
apparatus and methods - Part 1-2: Radio disturbance and
immunity measuring apparatus - Coupling devices for conducted
disturbance measurements
(CISPR 16-1-2:2014)**

Spécifications des méthodes et des appareils de mesure
des perturbations radioélectriques et de l'immunité aux
perturbations radioélectriques - Partie 1-2: Appareils de
mesure des perturbations radioélectriques et de l'immunité
aux perturbations radioélectriques - Dispositifs de couplage
pour la mesure des perturbations conduites
(CISPR 16-1-2:2014)

Anforderungen an Geräte und Einrichtungen sowie
Festlegung der Verfahren zur Messung der hochfrequenten
Störaussendung (Funkstörungen) und Störfestigkeit - Teil 1-
2: Geräte und Einrichtungen zur Messung der
hochfrequenten Störaussendung (Funkstörungen) und
Störfestigkeit - Koppeleinrichtungen zur Messung der
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Europäisches Komitee für Elektrotechnische Normung

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Foreword

The text of document CISPR/A/1051/FDIS, future edition 2 of CISPR 16-1-2, prepared by SC A "Radio-interference measurements and statistical methods" of IEC/TC CISPR "International special committee on radio interference" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 55016-1-2:2014.

The following dates are fixed:

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- | | | |
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| CISPR 16-2 Series | NOTE | Harmonized as EN 55016-2 Series (not modified). |
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Annex ZA

(normative)

Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

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<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
CISPR 16-1-1	2010	Specification for radio disturbance and immunity measuring apparatus and methods - Part 1-1: Radio disturbance and immunity measuring apparatus - Measuring apparatus	EN 55016-1-1	2010
CISPR 16-2-1	2014	Specification for radio disturbance and immunity measuring apparatus and methods - Part 2-1: Methods of measurement of disturbances and immunity - Conducted disturbance measurements	EN 55016-2-1	2014
CISPR 16-4-2	2011	Specification for radio disturbance and immunity measuring apparatus and methods - Part 4-2: Uncertainties, statistics and limit modelling - Measurement instrumentation uncertainty	EN 55016-4-2	2011
IEC 61000-4-6	2008	Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields	EN 61000-4-6	2009
IEC 60050	Series	International Electrotechnical Vocabulary - - Part 802: Ultrasonics		-



INTERNATIONAL STANDARD

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INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE
COMITÉ INTERNATIONAL SPÉCIAL DES PERTURBATIONS RADIOÉLECTRIQUES

BASIC EMC PUBLICATION
PUBLICATION FONDAMENTALE EN CEM

**Specification for radio disturbance and immunity measuring apparatus and methods –
Part 1-2: Radio disturbance and immunity measuring apparatus – Coupling devices for conducted disturbance measurements**

**Spécifications des méthodes et des appareils de mesure des perturbations radioélectriques et de l'immunité aux perturbations radioélectriques –
Partie 1-2: Appareils de mesure des perturbations radioélectriques et de l'immunité aux perturbations radioélectriques – Dispositifs de couplage pour la mesure des perturbations conduites**





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INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

COMMISSION
ELECTROTECHNIQUE
INTERNATIONALE

PRICE CODE
CODE PRIX
XD

ICS 33.100.10, 33.100.20

ISBN 978-2-8322-1412-1

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**INTERNATIONAL ELECTROTECHNICAL COMMISSION
INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE**

**SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY
MEASURING APPARATUS AND METHODS –**

**Part 1-2: Radio disturbance and immunity measuring apparatus –
Coupling devices for conducted disturbance measurements**

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This second edition cancels and replaces the first edition published in 2003 and its Amendment 1 (2004) and Amendment 2 (2006). This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) requirements from CISPR 22 for the AAN have been copied to this standard;
- b) the CDNE for measurement of disturbance voltage in the frequency range 30 MHz to 300 MHz is added;
- c) additional maintenance is included.

It has the status of a basic EMC publication in accordance with IEC Guide 107, *Electromagnetic compatibility – Guide to the drafting of electromagnetic compatibility publications*.

The text of this standard is based on the following documents:

FDIS	Report on voting
CISPR/A/1051/FDIS	CISPR/A/1059/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

A list of all parts of CISPR 16 series, under the general title *Specification for radio disturbance and immunity measuring apparatus and methods*, can be found on the IEC website.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY MEASURING APPARATUS AND METHODS –

Part 1-2: Radio disturbance and immunity measuring apparatus – Coupling devices for conducted disturbance measurements

1 Scope

This part of the CISPR 16 series specifies the characteristics and performance of equipment for the measurement of radio disturbance voltages and currents in the frequency range 9 kHz to 1 GHz.

NOTE In accordance with IEC Guide 107, CISPR 16 is a basic EMC standard for use by product committees of the IEC. As stated in Guide 107, product committees are responsible for determining the applicability of the EMC standard. CISPR and its sub-committees are prepared to co-operate with product committees in the evaluation of the value of particular EMC tests for specific products.

Specifications for ancillary apparatus are included for artificial mains networks, current and voltage probes and coupling units for current injection on cables.

It is intended that the requirements of this publication are fulfilled at all frequencies and for all levels of radio disturbance voltages and currents within the CISPR indicating range of the measuring equipment.

Methods of measurement are covered in the CISPR 16-2 series, and further information on radio disturbance is given in CISPR 16-3, while uncertainties, statistics and limit modelling are covered in the CISPR 16-4 series.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

CISPR 16-1-1:2010, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 1-1: Radio disturbance and immunity measuring apparatus – Measuring apparatus*

CISPR 16-2-1:2014, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 2-1: Methods of measurement of disturbances and immunity – Conducted disturbance measurements*

CISPR 16-4-2:2011, *Specification for radio disturbance and immunity measuring apparatus and methods – Part 4-2: Uncertainties, statistics and limit modelling – Measurement instrumentation uncertainty*

IEC 60050 (all parts), *International Electrotechnical Vocabulary* (available at <http://www.electropedia.org>)

IEC 61000-4-6:2008, *Electromagnetic compatibility (EMC) – Part 4-6: Testing and measurement techniques – Immunity to conducted disturbances, induced by radio-frequency fields*

koniec náhľadu – text ďalej pokračuje v platenej verzii STN